Notice of References Cited

Application/Control No. 10/735,673	Applicant(s)/l Reexamination GAZZARD, E	on
Examiner	Art Unit	
Awet A. Haile	2609	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0049731 A1	12-2001	Kuusinen et al.	709/223
*	В	US-2002/0006125 A1	01-2002	JOSSE et al.	370/354
*	С	US-6,370,390 B1	04-2002	Salin et al.	455/466
*	D	US-2002/0061756 A1	05-2002	Bleckert et al.	455/458
*	E	US-2002/0137532 A1	09-2002	Landais et al.	455/466
*	F	US-2002/0151307 A1	10-2002	Demarez et al.	455/445
*	G	US-2004/0017798 A1	01-2004	Hurtta et al.	370/352
*	Н	US-6,847,610 B1	01-2005	Suumaki et al.	370/230.1
*	1	US-6,888,822 B2	05-2005	Svensson et al.	370/353
*	J	US-7,006,478,B1	02-2006	Mizell et al.	370/338
	К	US-			
	L	US-			
	М	US-			

' FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
	R					
	s					
	Т			",		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.